TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK2602

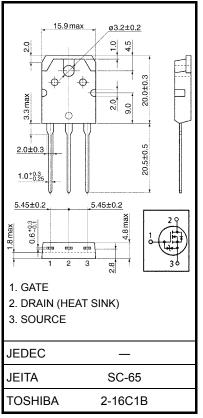
Switching Regulator Applications

Unit: mm

 $\begin{array}{ll} \bullet & Low \ drain-source \ ON \ resistance & : R_{DS} \ (on) = 0.9 \ \Omega \ (typ.) \\ \bullet & High \ forward \ transfer \ admittance & : |Y_{fs}| = 5.5 \ S \ (typ.) \\ \bullet & Low \ leakage \ current & : I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 600 \ V) \\ \bullet & Enhancement \ mode & : V_{th} = 2.0 \sim 4.0 \ V \ (V_{DS} = 10 \ V, \ I_{D} = 1 \ mA) \\ \end{array}$

Absolute Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	600	V	
Drain-gate voltage (Ro	_{SS} = 20 kΩ)	V_{DGR}	600	V	
Gate-source voltage		V _{GSS}	±30	V	
Drain current	DC (Note 1)	ID	6	Α	
	Pulse (Note 1)	I _{DP}	24	Α	
Drain power dissipation	r (Tc = 25°C)	P _D	125	W	
Single pulse avalanche	e energy (Note 2)	E _{AS}	345	mJ	
Avalanche current		I _{AR}	6	Α	
Repetitive avalanche e	nergy (Note 3)	E _{AR}	12.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature ra	ange	T _{stg}	-55~150	°C	



Weight: 4.6 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.0	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	50	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = 90 V, T_{ch} = 25°C (initial), L = 16.8 mH, R_G = 25 Ω , I_{AR} = 6 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.



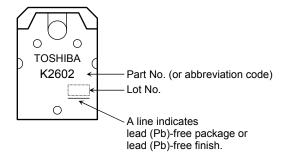
Electrical Characteristics (Ta = 25°C)

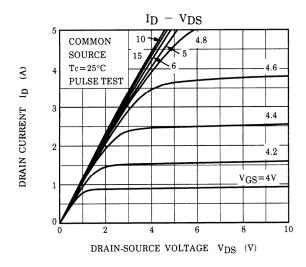
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±25 V, V _{DS} = 0 V	_	_	±10	μΑ
Gate-source bre	eakdown voltage	V (BR) GSS	I _G = ±10 μA, V _{DS} = 0 V	±30	_	_	V
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 600 V, V _{GS} = 0 V	_	_	100	μA
Drain-source br	eakdown voltage	I (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	600	_	_	V
Gate threshold v	oltage/	V_{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 3 A,		0.9	1.25	Ω
Forward transfer	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 3 A	2.0	5.5	_	S
Input capacitano	e	C _{iss}		-	1300	_	
Reverse transfer capacitance C _{rss}		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		130	_	pF
Output capacitance		Coss]	-	400	_]
Switching time	Rise time	t _r	$V_{GS} = \frac{10V}{0V} \int_{V_{OU}} V_{OU} dt$ $V_{GS} = \frac{10V}{0V} \int_{V_{OU}} R_{L} = 100\Omega$ $V_{DD} = \frac{300V}{300V}$ $V_{DD} = \frac{300V}{10V}$ $V_{DD} = \frac{300V}{10V}$	_	25	_	
	Turn-on time	t _{on}		_	45	_	ne
	Fall time	t _f		_	40	_	ns
	Turn-off time	t _{off}		_	150	_	
Total gate charg plus gate-drain)	•				30		
Gate-source charge		Q _{gs}	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}$		18	_	nC
Gate-drain ("miller") Charge		Q _{gd}			12	_	

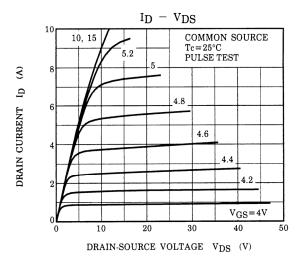
Source-Drain Ratings and Characteristics (Ta = 25°C)

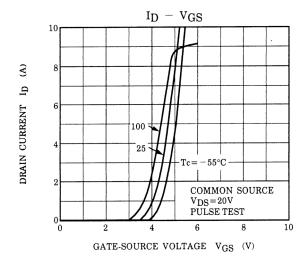
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	6	А
Pulse drain reverse current (Note 1)	I _{DRP}	-	_	_	24	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 6 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	$I_{DR} = 6 \text{ A}, V_{GS} = 0 \text{ V}, dI_{DR} / dt = 100 \text{ A} / \mu \text{s}$	_	1000	_	ns
Reverse recovery charge	Qrr		-	7	_	μC

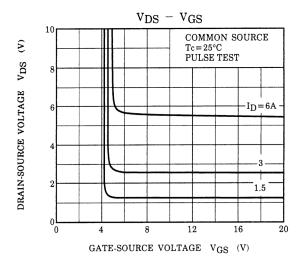
Marking

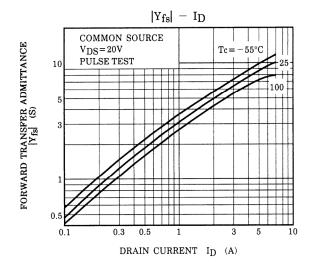


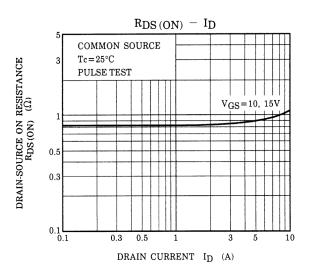




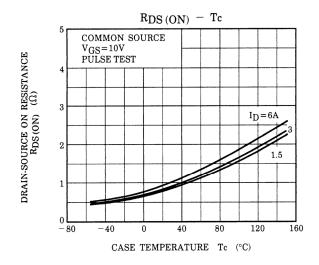


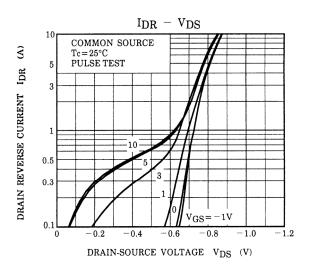


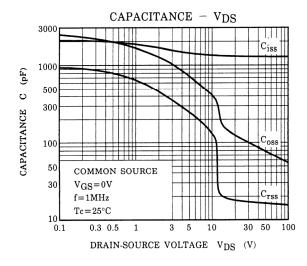


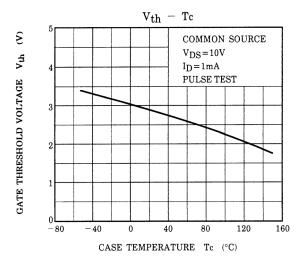


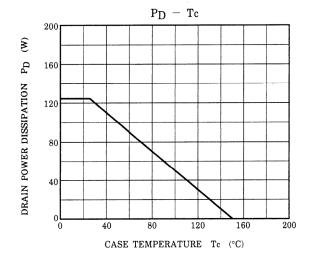
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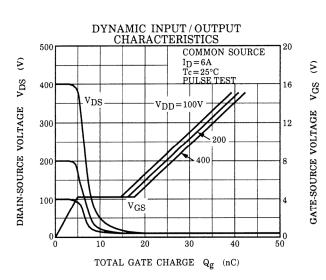


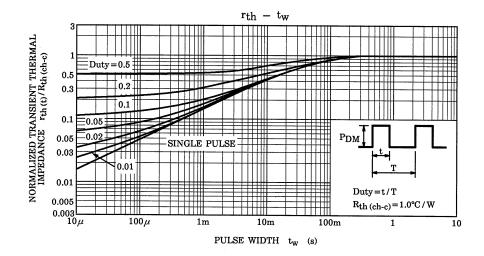


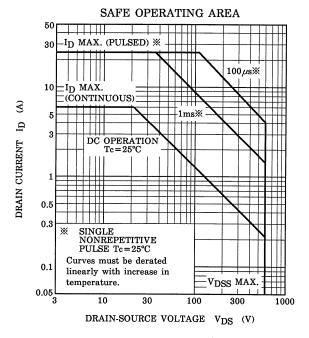


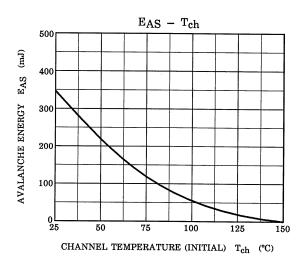


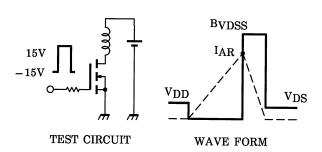












$$R_G = 25 \Omega$$

 $V_{DD} = 90 \text{ V}, L = 16.8 \text{ mH}$ $E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$

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20070701-EN

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